

REGULATORY COMPLIANCE











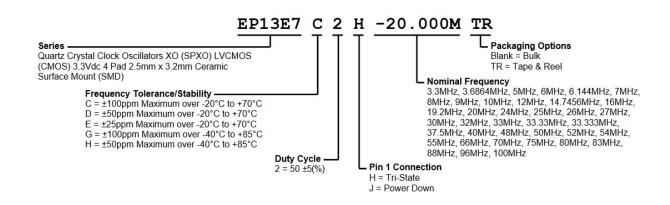
ITEM DESCRIPTION

Quartz Crystal Clock Oscillators XO (SPXO) LVCMOS (CMOS) 3.3Vdc 4 Pad 2.5mm x 3.2mm Ceramic Surface Mount (SMD)

ELECTRICAL SPECIFICATIONS		
Nominal Frequency	3.3MHz to 100MHz	
Frequency Tolerance/Stability	Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°, 260°C Reflow, Shock, and Vibration ±100ppm Maximum over -20°C to +70°C ±50ppm Maximum over -20°C to +70°C ±25ppm Maximum over -20°C to +70°C ±100ppm Maximum over -40°C to +85°C ±50ppm Maximum over -40°C to +85°C	
Aging at 25°C	±5ppm/Year Maximum	
Supply Voltage	3.3Vdc ±5%	
Input Current	12mA Maximum over Nominal Frequency of 3.3MHz to 25MHz 17mA Maximum over Nominal Frequency of 25.000001MHz to 50MHz 17mA Maximum over Nominal Frequency of 50.000001MHz to 75MHz 22mA Maximum over Nominal Frequency of 75.000001MHz to 90MHz 25mA Maximum over Nominal Frequency of 90.000001MHz to 100MHz	
Output Voltage Logic High (V _{он})	IOH = -8mA 90% of Vdd Minimum	
Output Voltage Logic Low (V _{OL})	IOL = +8mA 10% of Vdd Maximum	
Rise/Fall Time	Measured at 20% to 80% of waveform 6nSec Maximum over Nominal Frequency of 3.3MHz to 50MHz 4nSec Maximum over Nominal Frequency of 50.000001MHz to 75MHz 2nSec Maximum over Nominal Frequency of 75.000001MHz to 100MHz	
Duty Cycle	Measured at 50% of waveform 50 ±5(%)	
Load Drive Capability	30pF Maximum over Nominal Frequency of 3.3MHz to 50MHz 15pF Maximum over Nominal Frequency of 50.000001MHz to 100MHz	
Output Logic Type	CMOS	
Pin 1 Connection	Tri-State Power Down	
Pin 1 Input Voltage (Vih and Vil)	90% of Vdd Minimum or No Connect to Enable Output, 10% of Vdd Maximum to Disable Output	
Standby Current	30μA Maximum (Pin 1 = Ground)	
Disable Current	8mA Maximum (Pin 1 = Ground)	
Absolute Clock Jitter	350pSec Maximum over Nominal Frequency of 3.3MHz to 24.999999MHz 200pSec Maximum over Nominal Frequency of 25MHz to 100MHz	
Start Up Time	10mSec Maximum	
Storage Temperature Range	-55°C to +125°C	

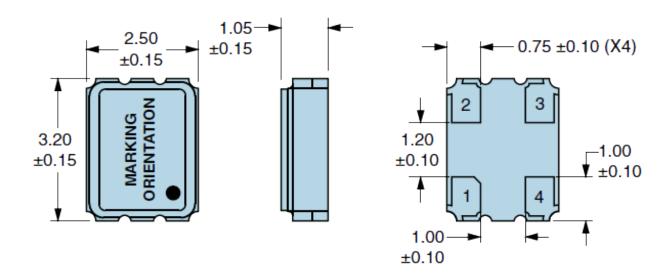


PART NUMBERING GUIDE

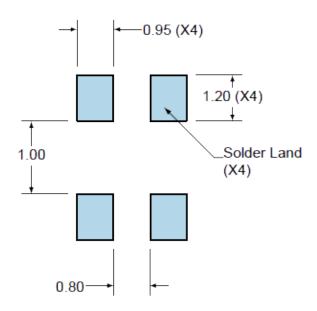




MECHANICAL DIMENSIONS



SUGGESTED SOLDER PAD LAYOUT



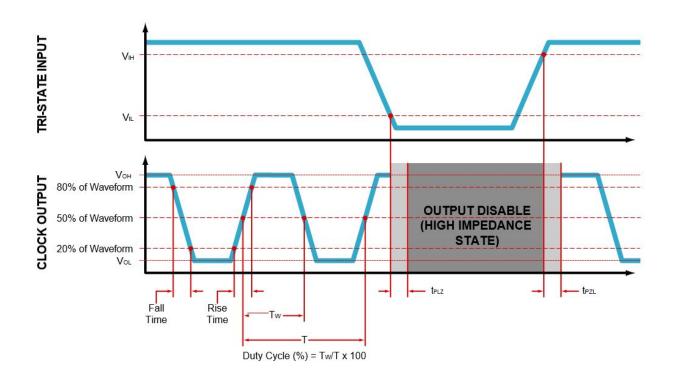
PIN	CONNECTION
1	Power Down Or Tri-State
2	Ground
	Ground
3	Output
4	Supply Voltage

All Tolerances are ±0.1

All Dimensions in Millimeters

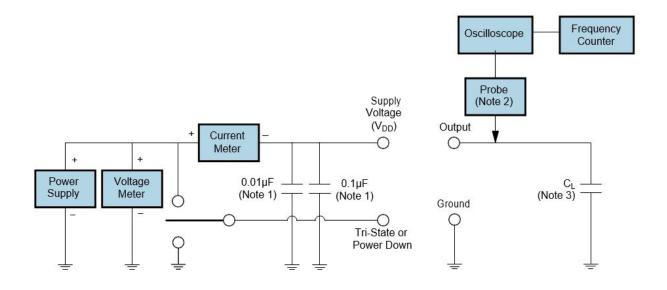


OUTPUT WAVEFORM & TIMING DIAGRAM





TEST CIRCUIT FOR CMOS OUTPUT



Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close (less

Than 2mm) to the package ground and supply voltage pin is required.

Note 2: A low input capacitance (<12pF), 10X Attentuation Factor, High Impedance (>10Mohms), and High bandwidth (>300MHz) Passive probe is recommended.

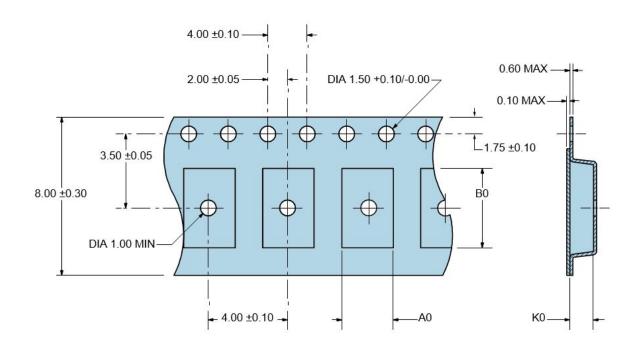
Note 3: Capacitance value CL includes sum of all probe and fixture capacitance. See applicable specification sheet for 'Load Drive Capability'.

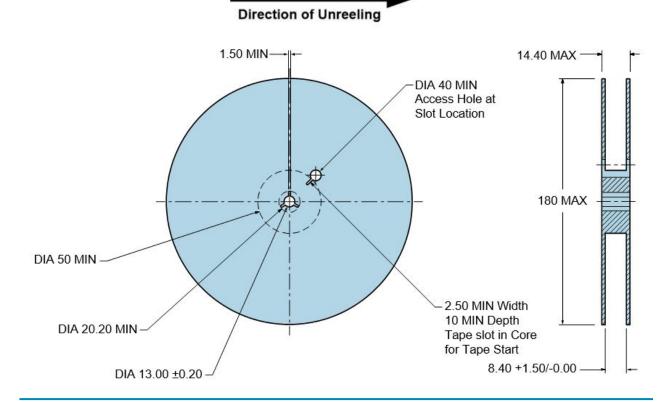


TAPE & REEL DIMENSIONS

Quantity per Reel: 1,000 Units

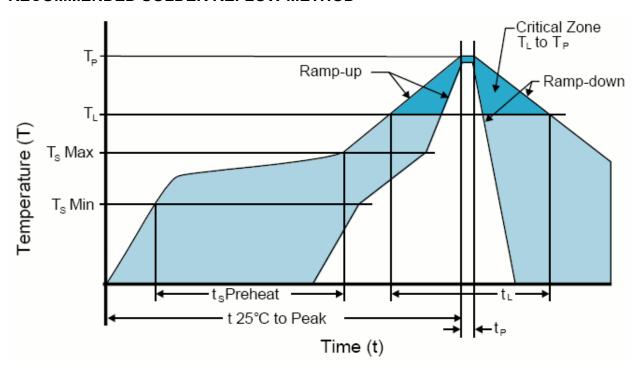
All Dimensions in Millimeters
Compliant to EIA-481







RECOMMENDED SOLDER REFLOW METHOD



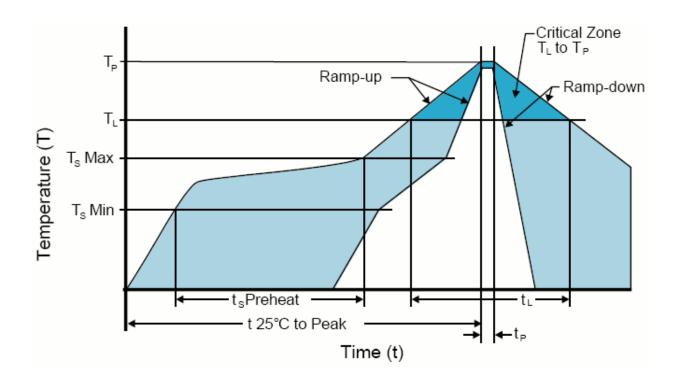
HIGH TEMPERATURE INFRARED/CONVECTION		
T _s MAX to T _L (Ramp-up Rate)	3°C/Second Maximum	
Preheat		
- Temperature Minimum (T _S MIN)	150°C	
- Temperature Typical (T _s TYP)	175°C	
- reinperature maximum (rs max)	200°C	
- Time (t _s MIN)	60 - 180 Seconds	
Ramp-up Rate (T _L to T _P)	3°C/Second Maximum	
Time Maintained Above:		
- Temperature (T _L)	217°C	
- Time (t _L)	60 - 150 Seconds	
Peak Temperature (T _P)	260°C Maximum for 10 Seconds Maximum	
Target Peak Temperature(T _P Target)	250°C +0/-5°C	
Time within 5°C of actual peak (tp)	20 - 40 Seconds	
Ramp-down Rate	6°C/Second Maximum	
Time 25°C to Peak Temperature (t)	8 Minutes Maximum	
Moisture Sensitivity Level	Level 1	
Additional Notes	Temperatures shown are applied to body of device.	

High Temperature Manual Soldering

260°C Maximum for 5 Seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)



RECOMMENDED SOLDER REFLOW METHOD



LOW TEMPERATURE INFRARED/CONVECTION		
T _s MAX to T _L (Ramp-up Rate)	5°C/Second Maximum	
Preheat		
- Temperature Minimum (T _S MIN)	N/A	
- Temperature Typical (T _s TYP)	150°C	
- Temperature Maximum(T _s MAX)	N/A	
- Time (t _s MIN)	60 - 120 Seconds	
Ramp-up Rate (T _L to T _P)	5°C/Second Maximum	
Time Maintained Above:		
- Temperature (T _L)	150°C	
- Time (t _L)	200 Seconds Maximum	
Peak Temperature (T _P)	240°C Maximum	
Target Peak Temperature(T _P Target)	240°C Maximum 2 Times/230°C Maximum 1Time	
Time within 5°C of actual peak (t _P)	10 Seconds Maximum 2 Times / 80 Seconds Maximum 1 Time	
Ramp-down Rate	5°C/Second Maximum	
Time 25°C to Peak Temperature (t)	N/A	
Moisture Sensitivity Level	Level 1	
Additional Notes	Temperatures shown are applied to body of device.	

Low Temperature Manual Soldering

185°C Maximum for 10 Seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

Mouser Electronics

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ABRACON:

EP13E7E2H-25.000M